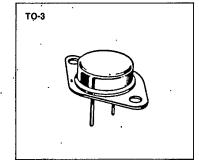
IRF420/421/422/423

POWER MOSFETS

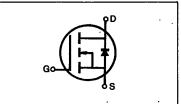
FEATURES

- Low R_{DS(on)} at high voltage
- Improved inductive ruggedness
- **Excellent high voltage stability**
- Fast switching times
- Rugged polysilicon gate cell structure
- Low input capacitance
- Extended safe operating area
- Improved high temperature reliability
- TO-3 package (High voltage)



PRODUCT SUMMARY

Part Number	V _{DS}	R _{DS(on)}	ID		
IRF420	,500V	3.0 🛭	2.5A		
IRF421	450V	3.0 Ω	2.5A		
IRF422	500V	4.0 Ω	2.0A		
IRF423	450V	4.0Ω	2.0A		



MAXIMUM RATINGS

Characteristic	Symbol	IRF420	IRF421	IRF422	IRF423	Unit
Drain-Source Voltage (1)	V _{DSS}	500	450	500	450	Vdc
Drain-Gate Voltage (R _{GS} =1.0MΩ) (1)	V _{DGR}	500	450	500	450	Vdc
Gâte-Source Voltage	V _{GS}		Vdc			
Continuous Drain Current T _C =25°C	lο	2.5	2.5	2.0	2.0	Adc
Continuous Drain Current T _C =100°C	lο	1.5	1.5	1.0	1.0	Adc
Drain Current—Pulsed (3)	I _{DM}	10	10	8.0	8.0	Adc
Gate Current—Pulsed	I _{GM}		Adc			
Total Power Dissipation @ T _C =25°C Derate above 25°C	P _D		Watts W/°C			
Operating and Storage Junction Temperature Range	T _J , Tstg		°C			
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	T _L ·		°C			

Notes: (1) T_J=25°C to 150°C

(2) Pulse test: Pulse width≤300μs, Duty Cycle≤2%
 (3) Repetitive rating: Pulse width limited by max. Junction temperature



128

IRF420/421/422/423

98 DE 7964142 0005130 5

N-CHANNEL **POWER MOSFETS**

ELECTRICAL CHARACTERISTICS (T_C=25°C unless otherwise specified)

Characteristic	Symbol	Туре	Min	Тур	Max	Units	Test Conditions	
Drain-Source Breakdown	BVpss	IRF420 IRF422	500	_	_	٧	V _{GS} =0V	
Voltage		IRF421 IRF423	450	_	_	٧	I _D =250μA	
Gate Threshold Voltage	V _{GS(th)}	ALL	2.0	-	4.0	>	V _{DS} =V _{GS} , I _D =250μA	
Gate-Source Leakage Forward	lass	ALL	١	_	100	nΑ	V _{GS} =20V	
Gate-Source Leakage Reverse	lgss	ALL	1	_	-100	nΑ	V _{GS} =-20V	
Zero Gate Voltage	ipss	ALL		-	250	μΑ	V _{DS} =Max. Rating, V _{GS} =0V	
Drain Current	.500	71	-	_	1000	μΑ	V _{DS} =Max. Rating×0.8, V _{GS} =0V, T _C =125°C	
On-State Drain-Source	I _{D(on)}	IRF420 IRF421	2.5	-	_	A	V _{DS} >I _{D(on)} ×R _{DS(on) max.} , V _{GS} =10V	
Current (2)	U(On)	IRF422 IRF423	2.0	<u> </u>	1	. A		
Static Drain-Source On-State	R _{DS(on)}	IRF420 IRF421	1	2.5	3.0	Ω	V =40V 1 =4.04	
Resistance (2)		IRF422 IRF423	_	3.0	4.0	Ω	V _{GS} =10V, I _D =1.0A	
Forward Transconductance (2)	Qfs	ALL	1.0	1.75	_	v	$V_{DS}>I_{D(on)}\times R_{DS(on)\ max.}$, $I_D=1.0A$	
Input Capacitance	Ciss	ALL	_	300	600	рF		
Output Capacitance	Coss	ALL	_	75	150	рF	V _{GS} =0V, V _{DS} =25V, f=1.0MHz	
Reverse Transfer Ĉapacitance	Crss	ALL	-	20	40	рF		
Turn-On Delay Time	td(on)	ALL	_		60	ns		
Rise Time .	tr	ALL	-	_	50	ns	$V_{DD} = 0.5BV_{DSS}, I_D = 1.0A, Z_O = 50 \Omega,$	
Turn-Off Delay Time	t _{d(off)}	ALL	-	_	60	ns	(MOSFET switching times are essentially independent of operating temperature.)	
Fall Time	tr	ALL	_	_	30	ns		
Total Gate Charge (Gate-Source Plus Gate-Drain)	Q ₀	ALL	-	11	15	nC	V _{GS} =10V, I _D =3.0A, V _{DS} =0.8 Max. Rating	
Gate-Source Charge	Qgs	ALL	_	5.0		пС	(Gate charge is essentially independent of operating temperature.)	
Gate-Drain ("Miller") Charge	Q _{gd}	ALL	-	6.0	_	nC	opening companies of	

THERMAL RESISTANCE

Junction-to-Case	Rttuc	ALL		_	3.12	K/W	
Case-to-Sink	RthCS	ALL	-	0.1	1	K/W	Mounting surface flat, smooth, and greased
Junction-to-Ambient	RthJA	ALL	_	_	30	K/W	Free Air Operation

Notes: (1) T_J=25°C to 150°C (2) Pulse test: Pulse width≼300μs, Duty Cycle≼2% (3) Repetitive rating: Pulse width limited by max. junction temperature





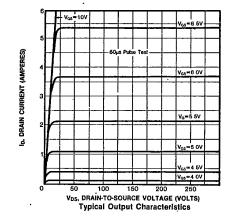
--- 98 DE 7964142 0005131 7 IRF420/421/422/423

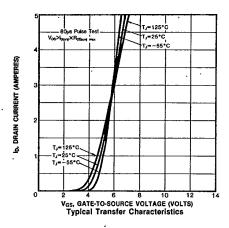
N-CHANNEL POWER MOSFETS

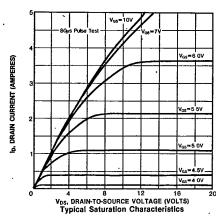
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

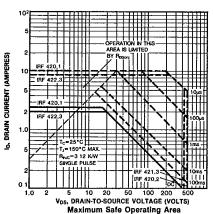
Characteristic	Symbol	Туре	Min	Тур	Max	Units	Test Conditions
Continuous Source Current (Body Diode)	ls	IRF420 IRF421	-	_	2.5	Α	
	l's	IRF422 IRF423		_	2.0	- A	Modified MOSFET symbol showing the integral
Pulse Source Current (Body Diode) (3)	IsM	IRF420 IRF421	_	_	10	Α	reverse P-N junction rectifier
		IRF422 IRF423	_	_	8.0	Α	
Diode Forward Voltage (2)		IRF420 IRF421	_	-	1.4	V	T _C =25°C, I _S =2.5A, V _{GS} =0V
Sidd Forward Vollago (2)		IRF422 IRF423		_	1.3	V	T _C =25°C, I _S =2.0A, V _{GS} =0V
Reverse Recovery Time	trr	ALL		600	_	ns	T _J =150°C, I _F =2.5A, dI _F /dt=100A/μs

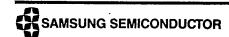
Notes: (1) T_J=25°C to 150°C (2) Pulse test: Pulse width≤300μs, Duty Cycle≤2% (3) Repetitive rating: Pulse width limited by max. junction temperature









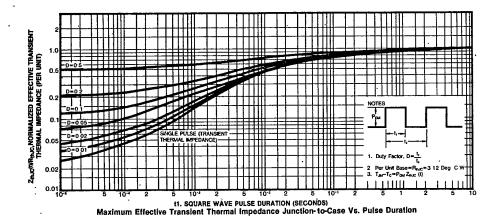


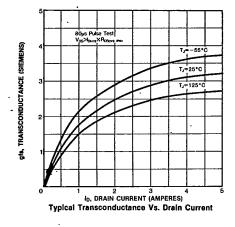
ζ

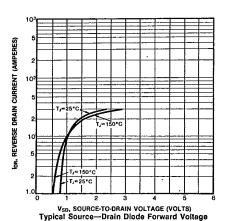
98D 05132

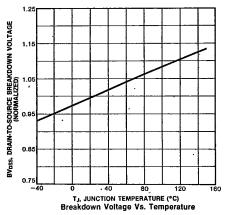
D T-39-11

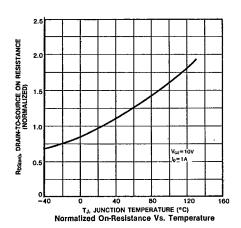
N-CHANNEL POWER MOSFETS













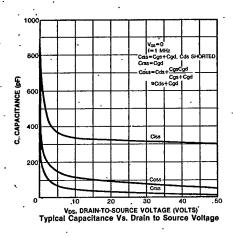


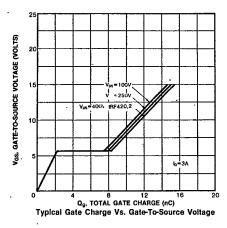


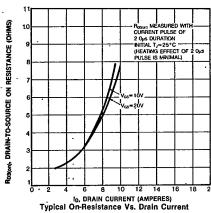
7964142 SAMSUNG SEMICONDUCTOR INC

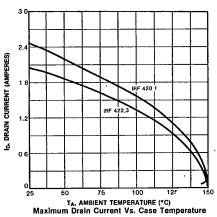
98D 05133 D T-39-11

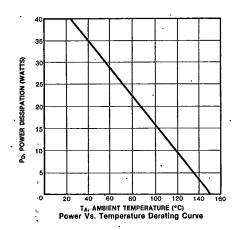
98 DE 7964142 0005133 0 IRF420/421/422/423 N-CHANNEL POWER MOSFETS











SAMSUNG SEMICONDUCTOR

132

Ţ